

Amendments to the Specification:

Please replace paragraph [0014] with the following amended paragraph:

[0014] In one embodiment, the top holding plate 20 is coupled to the bottom holding plate 30 to permit rotation of the top holding plate 20 from a first, open position (FIGS. 1, 2 and 4A) in a direction indicated by arrows 100 to a second, closed position (FIG. 4C). This rotational movement is illustrated in detail in FIGS. 4A-4C. In one embodiment, top holding plate 20 is pivotally and slidably joined with an elongated slot vertical guide-31 that serves as a vertical guide. ~~Vertical guide~~Elongated slot 31 is configured to guide allow top holding plate 20 ~~to~~ vertically self-adjust from the open position shown in FIG. 4A to the closed position shown in FIG. 4C, which is proximate cleaning cartridge 40, by allowing it to slide and pivot within the elongated slot. In the closed position the top holding plate 20 is positioned over the bottom holding plate 30 so that probe pins 62 of the probe head 60 contact the absorbent pad 46 within the chamber 42 of the cleaning cartridge 40 (FIGS. 4C, 5 and 6). In one embodiment, the top holding plate 20 includes a plurality of guides 22 and the bottom holding plate 30 includes a plurality of holes or slots 32 for receiving the guides 22. The guides 22 and slots 32 cooperate to provide a predetermined alignment of the top holding plate 20 and the bottom holding plate 30. FIGS. 5 and 6 provide detailed views of the contact of probe pins 62 of the probe head assembly 60 and the absorbent pad 46 of the cleaning cartridge 40.